

<b>Notice of References Cited</b>	Application/Control No. 10/749,532	Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0113714 A1	06-2003	Belcher et al.	435/5
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Freeman et al, Science, 267, 1995, 1629-1632.□□□□
	V	Puntes et al, Science, 291, 3/2001, 2115-17.
	W	Lee et al, Sience, 296,5/2002, 892-95
	X	Naik et al, Nature, 2002, 169-172.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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